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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary)		Complete if Known			
		Application Number	10/800,697 Conf.#1773		
		Filing Date	March 16, 2004		
		First Named Inventor	Yong C. PARK		
		Art Unit	2627		
		Examiner Name	N. A. Danielsen		
Sheet	1	of	4	Attorney Docket Number	0465-1157P

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. ¹	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code ² (if known)			
	AA*	US-20010044873	11-22-2001	WILSON et al.	
	AB*	US-20030196133-A1	10-16-2003	Park et al.	
	AC*	US-20040153905-A1	08-05-2004	Park et al.	
	AD*	US-4,406,000-A	09-20-1983	Shoji et al.	
	AE*	US-4,774,700-A	09-27-1988	Satoh et al.	
	AF*	US-4,833,665-A	05-23-1989	Tokumitsu et al.	
	AG*	US-4,949,326-A	08-14-1990	Takagi et al.	
	AH*	US-5,075,804-A	12-24-1991	Deyring	
	AI*	US-5,111,444-A	05-05-1992	Fukushima et al.	
	AJ*	US-5,270,877-A	12-14-1993	Fukushima et al.	
	AK*	US-5,271,018-A	12-14-1993	Chan	
	AL*	US-5,283,790-A	02-01-1994	Kawashita et al.	
	AM*	US-5,404,357-A	04-04-1995	Ito et al.	

	AN*	US-5,442,614-A	08-15-1995	Tamegai et al.	
	AO*	US-5,508,989-A	04-16-1996	Funahashi et al.	

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		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)				
	BA	CN-1164091-A	11-05-1997	Hideki Takahashi		Abstract
	BB	EP-0 383 298	08-22-1990	Sako, Yoichiro		✓
	BC	EP-0 559 468-A2	09-08-1993	Tamegai, Masahiro		✓
	BD	EP-0 798 710	10-01-1997	Takahashi, Hideki		✓
	BE	EP-0 837 472-A2	04-22-1998	Mine, Norichika		✓
	BF	EP-0 845 780	06-03-1998	Nakamura, Yoshimitsu et al.		✓

Examiner Signature		Date Considered	
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	AP*	US-5,526,335-A	06-11-1996	Tamegai et al.	
	AQ*	US-5,528,571-A	06-18-1996	Funahashi et al.	
	AR*	US-5,541,903-A	07-30-1996	Funahashi et al.	
	AS*	US-5,553,045-A	09-03-1996	Obata et al.	
	AT*	US-5,623,470-A	04-22-1997	Asthana et al.	
	AU*	US-5,666,335-A	09-09-1997	Horibe et al.	
	AV	US-5,715,221-A	02-03-1998	Ito et al.	
	AW*	US-5,737,290-A	04-07-1998	Ohmori et al.	
	AX*	US-5,739,519-A	04-14-1998	Tsuchiya et al.	
	AX*	US-5,740,349-A	04-14-1998	Hasbun et al.	
	AZ*	US-5,745,444-A	04-28-1998	Ichikawa et al.	
	AA1*	US-5,818,654-A	10-06-1998	Reddy et al.	
	AB1*	US-5,841,748-A	11-24-1998	Yamamuro et al.	
	AC1*	US-5,859,823-A	01-12-1999	Yamamuro et al.	
	AD1*	US-5,883,867-A	03-16-1999	Yamamuro et al.	
	AE1*	US-6,025,966-A	02-15-2000	Nemazie et al.	
	AF1*	US-6,031,804-A	02-29-2000	Yamamuro et al.	
	AK1*	US-6,038,209-A	03-14-2000	Satoh et al.	
	AG1*	US-6,049,515-A	04-11-2000	Yamamuro et al.	

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	BQ	EP-0 866 456-A1	09-23-1998	Gotoh, Yoshiho et al.		✓
	BR	EP-0 952 573-A3	10-27-1998	Ko, Jung-wan		✓
	BS	GB-2 332 555-A	06-23-1999	Hiroyuki Ohata et al.		✓
	BT	JP-02-23417	01-25-1990	Fukushima Yoshihisa		Abstract
	BU	JP-05-078109	03-30-1993	Takahashi Yukio et al.		Abstract
	BV	JP-05-114247-A	05-07-1993	Nakagawa Masaaki		Abstract

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	AI1*	US-6,160,778-A	12-12-2000	Ito et al.	
	AJ1*	US-6,212,647-B1	04-03-2001	Sims, III et al.	
	AK1*	US-6,279,118-B1	08-21-2001	Kang et al.	
	AL1*	US-6,282,365-B1	08-28-2001	Gotoh et al.	
	AM1*	US-6,292,445-B1	09-18-2001	Ito et al.	
	AO1*	US-6,314,235-B1	11-06-2001	Gotoh et al.	
	AP1*	US-6,377,524-B1	04-23-2002	Ko et al.	
	AQ1*	US-6,389,569-B1	05-14-2002	Chung et al.	
	AR1*	US-6,453,384-B1	09-17-2002	Park et al.	
	AS1*	US-6,526,522-B1	02-25-2003	Park et al.	
	AT1*	US-6,631,106-B1	10-07-2003	Numata et al.	
	AU1*	US-6,782,488-B1	08-24-2004	Park et al.	
	AV1*	US-7,139,935-B2	11-21-2006	Park et al.	
	AW2*	US-7,146,527-B2	12-05-2006	Park et al.	
	AX2*	US-7,206,267-B2	04-17-2007	Park et al.	

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		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)				
	BW	JP-05-342759-A	12-24-1993	Shimada Toshiyuki et al.		Abstract
	BX	JP-06-5001	01-14-1994	Sawa Kazutoshi		Abstract
	BX	JP-07-057397-A	03-03-1995	Sato Shinichi		Abstract
	BZ	JP-07-57398	03-03-1995	Funabashi Takeshi et al.		Abstract

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	BS	JP-08-171461-A	07-02-1996	Ichikawa Norimoto et al.		Abstract
	BT	JP-08-249659-A	09-27-1996	Tsuru Tetsuo		Abstract
	BU	JP-09-231682-A	09-05-1997	Yamamuro Mikio		Abstract
	BV	JP-09-259538-A	10-03-1997	Yamamura Mikio		Abstract
	BW	JP-09-259547	10-03-1997	Yamamuro Mikio		Abstract
	BX	WO-97/07505	02-27-1997	Nakamura et al.		Abstract
	BY	WO-97/35309	09-25-1997	Takagi et al.		Abstract

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials	Cite No. ¹	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T ²

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